

Notice of References Cited	Application/Control No. 10/715,641	Applicant(s)/Patent Under Reexamination CHIU ET AL.	
	Examiner John A. McPherson	Art Unit 1756	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0173075	11-2002	Tie et al.	438/108
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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